



DESCRIPTION

The AM7423 is available in DFN8(3.3x3.3) package.

ORDERING INFORMATION

Package Type	Part Number	
DFN8 (3.3x3.3)	J8	AM7423J8R
		AM7423J8VR
Note	V: Halogen free Package R: Tape & Reel SPQ: 3,000pcs/ Reel	
AiT provides all RoHS products Suffix " V " means Halogen free Package		

FEATURES

- -20V/-95A,
 $R_{DS(ON)} = 3.6m\Omega(max.) @ V_{GS} = -10V$
 $R_{DS(ON)} = 4.6m\Omega(max.) @ V_{GS} = -4.5V$
 $R_{DS(ON)} = 7m\Omega(max.) @ V_{GS} = -2.5V$
 $R_{DS(ON)} = 10m\Omega(max.) @ V_{GS} = -1.8V$
- HBM ESD protection level of 2.3kV typical
- 100% UIS + R_G Tested
- Reliable and Rugged

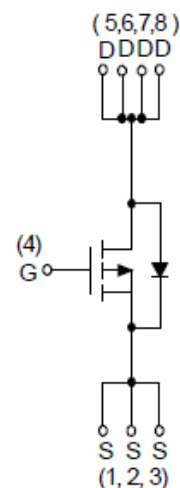
Note: The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

- Available in DFN8(3.3x3.3) package.

APPLICATION

- Power Management in Notebook Computer, Portable Equipment and Battery Powered Systems.

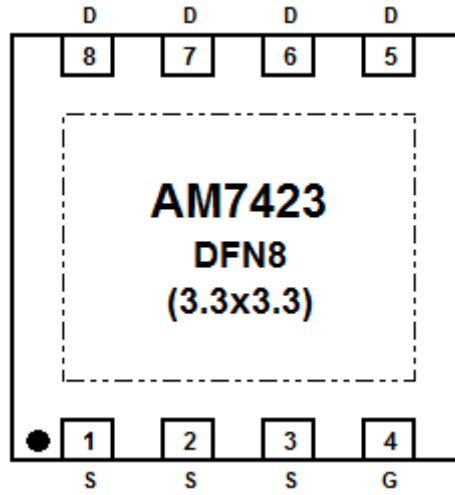
PIN DESCRIPTION



P-Channel MOSFET



PIN DESCRIPTION



Top View

Pin #	Symbol	Function
1	S	Source
2	S	Source
3	S	Source
4	G	Gate
5	D	Drain
6	D	Drain
7	D	Drain
8	D	Drain



ABSOLUTE MAXIMUM RATINGS

T_A = 25°C, unless Otherwise Noted

V _{DSS} , Drain-Source Voltage		-20V
V _{GSS} , Gate-Source Voltage		±12V
I _D ^{NOTE1} , Continuous Drain Current (V _{GS} =-4.5V)	T _A =25°C	-25A
	T _A =70°C	-20A
I _{DM} ^{NOTE1} , Pulsed Drain Current (V _{GS} =-4.5V)		-100 *
I _D ^{NOTE3} , Continuous Drain Current	T _C =25°C	-95A
	T _C =100°C	-60A
I _S ^{NOTE1} , Diode Continuous Forward Current		-50A
T _J , Maximum Junction Temperature		150°C
I _{AS} ^{NOTE4} , Avalanche Current, Single pulse	L=0.5mH	-22A
E _{AS} ^{NOTE4} , Avalanche Energy, Single pulse	L=0.5mH	121mJ
T _{STG} , Storage Temperature Range		-55°C~ 150°C
P _D ^{NOTE1} , Maximum Power Dissipation	T _A =25°C	4.2W
	T _A =70°C	2.7W
P _D ^{NOTE3} , Maximum Power Dissipation	T _C =25°C	62.5W
	T _C =100°C	25W
R _{θJA} ^{NOE1,2} , Thermal Resistance-Junction to Ambient	t ≤ 10s	30°C/W
	Steady State	70°C/W
R _{θJC} ^{NOTE3} , Thermal Resistance-Junction to Case		2°C/W

Stress beyond above listed "Absolute Maximum Ratings" may lead permanent damage to the device. These are stress ratings only and operations of the device at these or any other conditions beyond those indicated in the operational sections of the specifications are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

NOTE *: Package limited.

NOTE1: Surface Mounted on 1in² pad area, t ≤ 10sec.

NOTE2: Maximum under Steady State conditions is 75 °C/W.

NOTE3: The power dissipation P_D is based on T_{J(MAX)} = 150°C, and it is useful for reducing junction-to-case thermal resistance (R_{θJC}) when additional heat sink is used.

NOTE4: UIS tested and pulse width limited by maximum junction temperature 150oC (initial temperature T_J=25°C).



ELECTRICAL CHARACTERISTICS

T_A = 25°C, unless Otherwise Noted

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _{DS} =-250μA	-20	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-16V, V _{GS} =0V T _J =85°C	-	-	-1 -30	μA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _{DS} =-250μA	-0.4	-	-0.9	V
Gate Leakage Current	I _{GSS}	V _{GS} =±12V, V _{DS} =0V	-	-	±100	nA
Drain-Source On-state Resistance	R _{DS(ON)} NOTE5	V _{GS} =-10V, I _{DS} =-20A	-	3	3.6	mΩ
		V _{GS} =-4.5V, I _{DS} =-20A	-	3.6	4.6	
		V _{GS} =-2.5V, I _{DS} =-20A	-	4.9	7	
		V _{GS} =-1.8V, I _{DS} =-10A	-	7	10	
Diode Characteristics						
Diode Forward Voltage	V _{SD} NOTE5	I _{SD} =-1A, V _{GS} =0V	-	-0.5	-1.0	V
Reverse Recovery Time	t _{rr} NOTE6	I _{SD} =-20A, dI _{SD} /dt=100A/μs	-	33	-	ns
Reverse Recovery Charge	Q _{rr} NOTE6		-	17	-	nC
Dynamic Characteristics NOTE6						
Input Capacitance	C _{iss}	V _{GS} =0V, V _{DS} =-10V, Frequency=1.0MHz	-	5360	-	pF
Output Capacitance	C _{oss}		-	1030	-	
Reverse Transfer Capacitance	C _{rss}		-	820	-	
Gate Resistance	R _G	V _{GS} =0V, V _{DS} =0V, F=1MHz	-	3	-	Ω
Turn-on Delay Time	t _{d(ON)}	V _{DD} =-10V, R _L =10Ω, I _{DS} =-1A, V _{GEN} =-4.5V, R _G =6Ω	-	19	-	ns
Turn-on Rise Time	t _r		-	25	-	
Turn-off Delay Time	t _{d(OFF)}		-	228	-	
Turn-off Fall Time	t _f		-	72	-	
Gate Charge Characteristics NOTE6						
Total Gate Charge	Q _g	V _{DS} =-10V, V _{GS} =-4.5V, I _{DS} =-20A	-	54	-	nC
Gate-Source Charge	Q _{gs}		-	4.1	-	
Gate-Drain Charge	Q _{gd}		-	17	-	

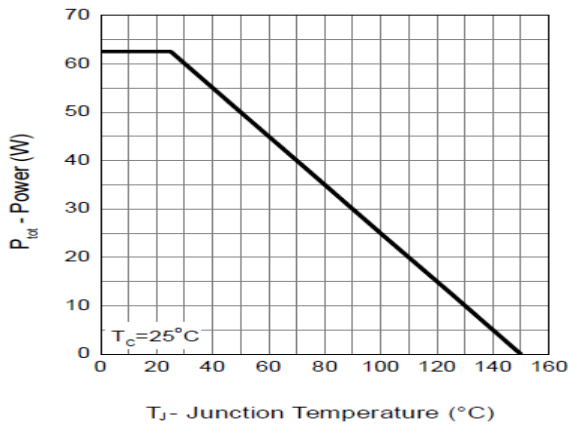
NOTE5: Pulse test; pulse width≤300μs, duty cycle≤2%.

NOTE6: Guaranteed by design, not subject to production testing.

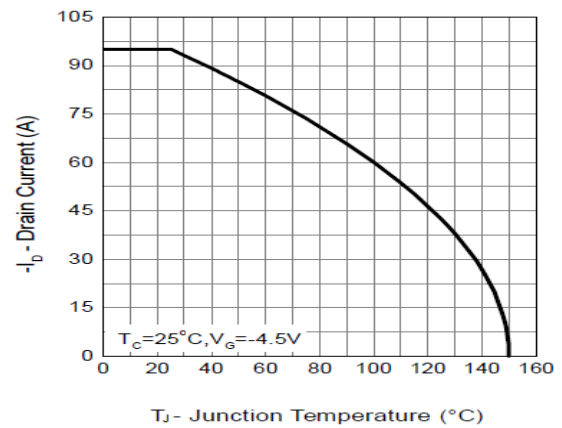


TYPICAL PERFORMANCE CHARACTERISTICS

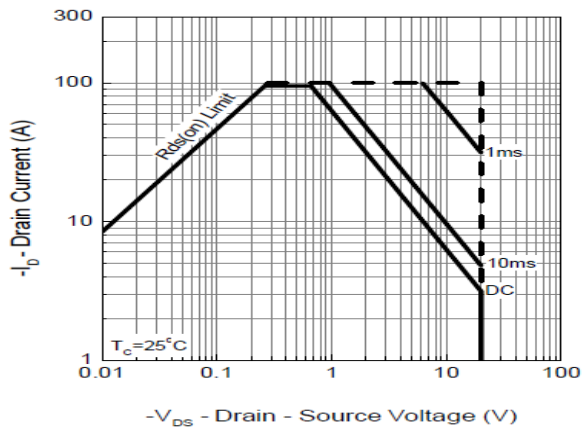
1. Power Dissipation



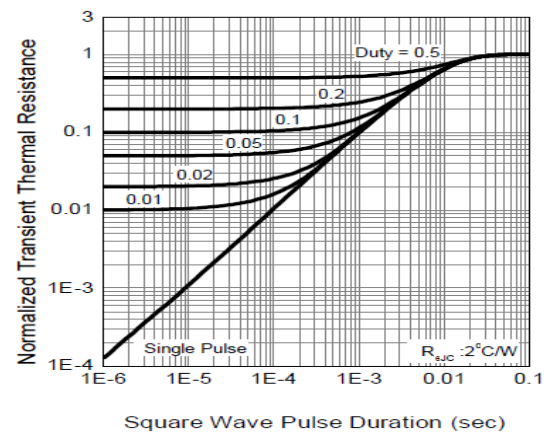
2. Drain Current



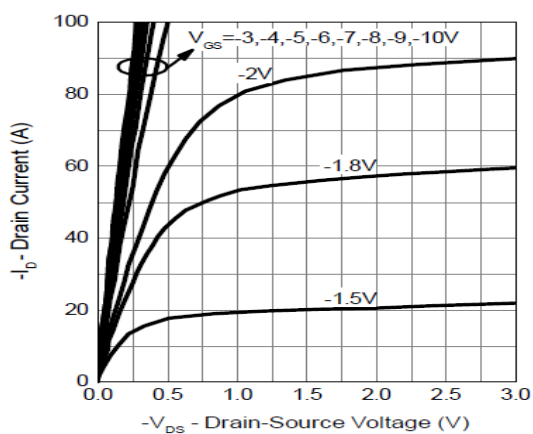
3. Safe Operation Area



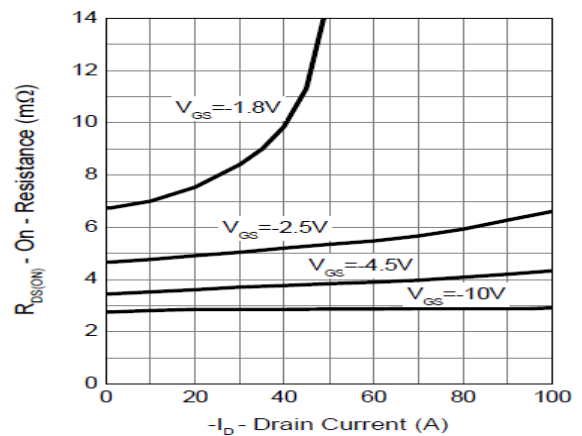
4. Thermal Transient Impedance



5. Output Characteristics

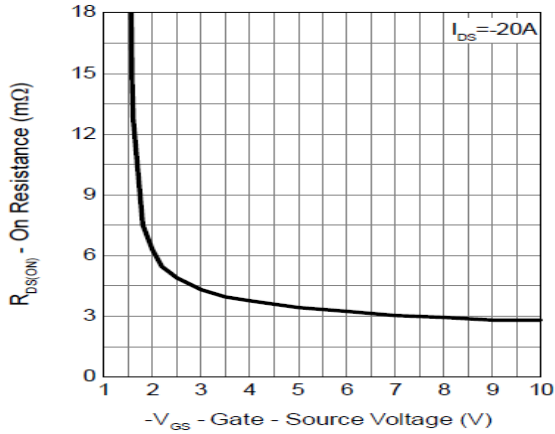


6. Drain-Source On Resistance

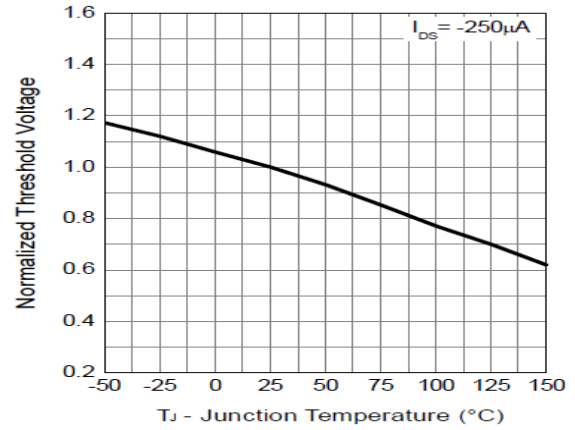




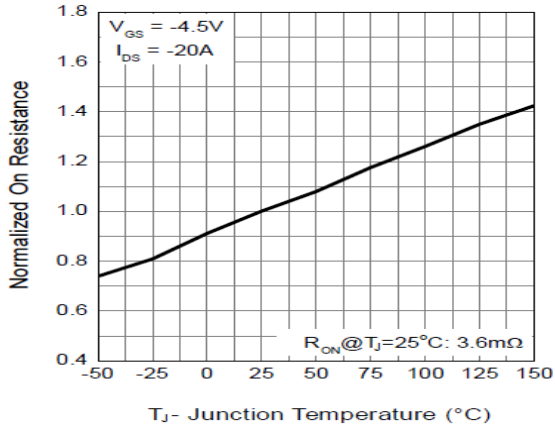
7. Gate-Source On Resistance



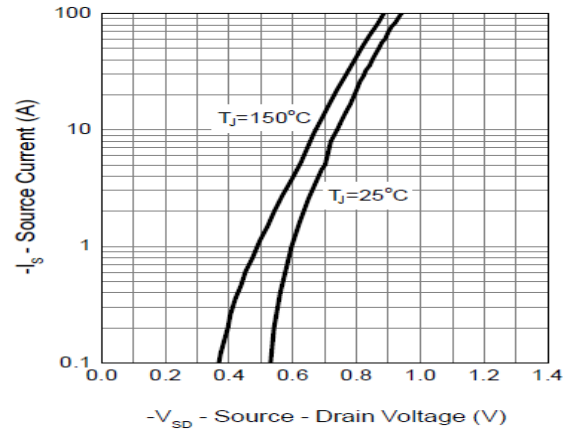
8. Gate Threshold Voltage



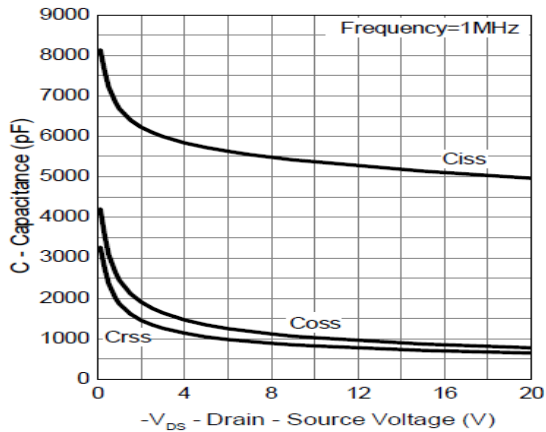
9. Drain-Source On Resistance



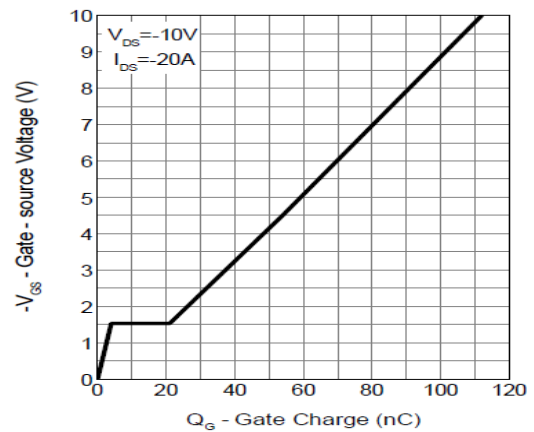
10. Source-Drain Diode Forward



11. Capacitance



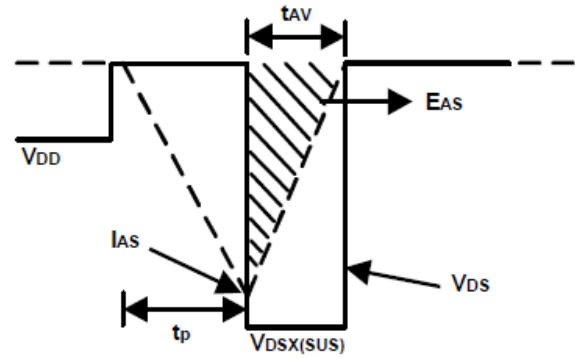
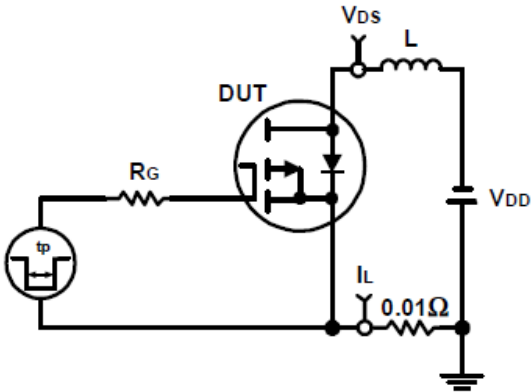
12. Gate Charge



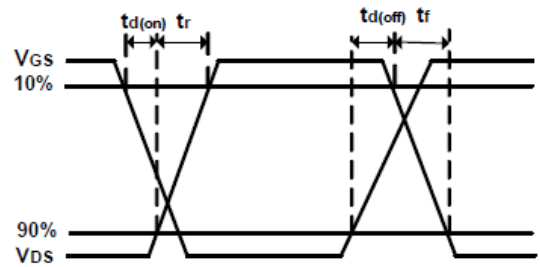
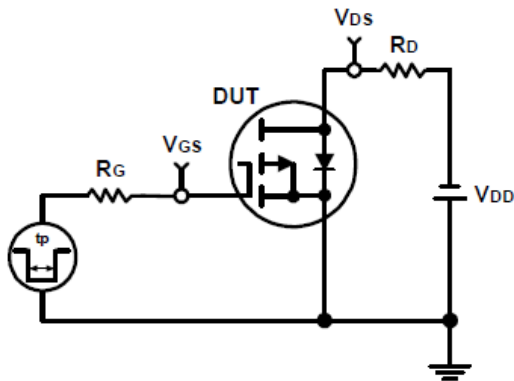


DETAILED INFORMATION

Avalanche Test Circuit and Waveforms



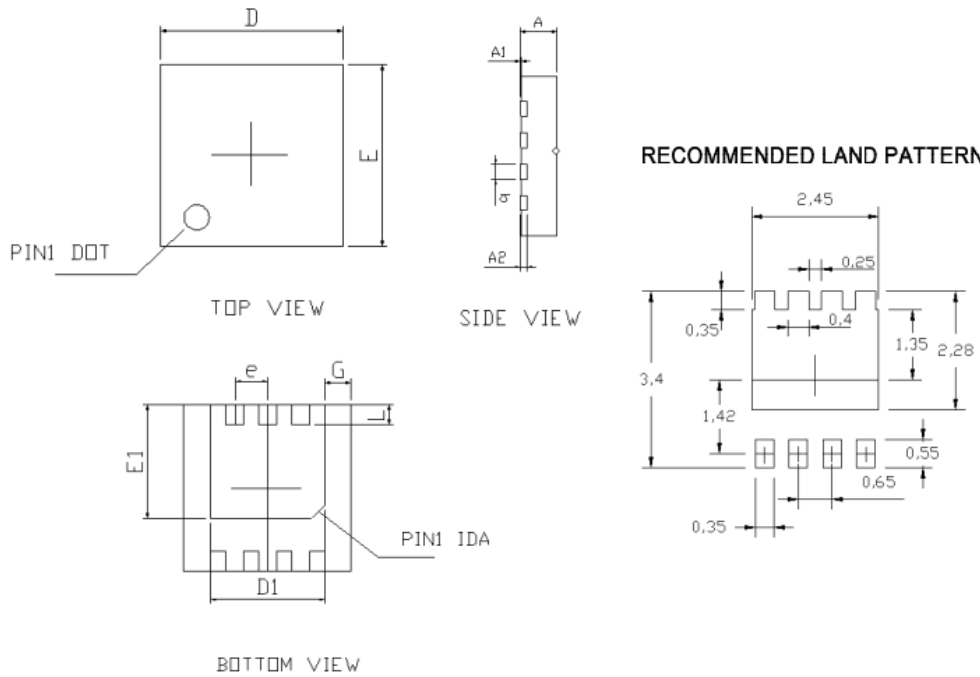
Switching Time Test Circuit and Waveforms





PACKAGE INFORMATION

Dimension in DFN8 (Unit: mm)



Symbol	MILLIMETERS		INCHES	
	Min	Max	Min	Max
A	0.700	0.800	0.028	0.032
A1	0.000	0.050	0.000	0.002
A2	0.100	0.250	0.004	0.010
b	0.240	0.350	0.009	0.014
D	3.150	3.400	0.124	0.134
D1	2.100	2.350	0.083	0.093
E	3.150	3.400	0.124	0.134
E1	2.150	2.350	0.850	0.093
e	0.600	0.700	0.024	0.028
G	0.475	0.575	0.019	0.023
L	0.350	0.450	0.014	0.018



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